

October 2008

FDS4897AC Dual N & P-Channel PowerTrench[®] MOSFET

FDS4897AC Dual N & P-Channel PowerTrench[®] MOSFET

N-Channel: 40 V, 6.1 A, 26 m $\Omega\,$ P-Channel: -40 V, -5.2 A, 39 m $\Omega\,$

Features

Q1: N-Channel

- Max $r_{DS(on)}$ = 26 m Ω at V_{GS} = 10 V, I_D = 6.1 A
- Max $r_{DS(on)}$ = 31 m Ω at V_{GS} = 4.5 V, I_D = 5.6 A

Q2: P-Channel

- Max $r_{DS(on)}$ = 39 m Ω at V_{GS} = -10 V, I_D = -5.2 A
- Max $r_{DS(on)}$ = 65 m Ω at V_{GS} = -4.5 V, I_D = -4.1 A
- 100% UIL Tested
- RoHS Compliant

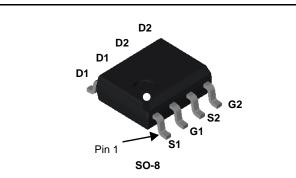


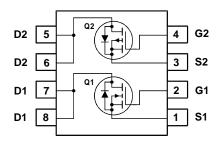
General Description

These dual N- and P-Channel MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench[®] process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

Applications

- Inverter
- Power Supplies





MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units	
V _{DS}	Drain to Source Voltage		40	-40	V	
V _{GS}	Gate to Source Voltage		±20	±20	V	
	Drain Current - Continuous			6.1	-5.2	^
Pulsed				24	-24	- A
	Power Dissipation for Dual Operation			2	.0	
P _D	Power Dissipation for Single Operation	T _A = 25 °C	(Note 1a)	1	.6	W
		T _A = 25 °C	(Note 1b)	0	.9	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	37	73	mJ
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to	+150	°C

Thermal Characteristics

R_{\thetaJC}	Thermal Resistance, Junction to Case,	(Note 1)	40	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Ambient,	(Note 1a)	78	0/10

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDS4897AC	FDS4897AC	SO-8	13 "	12 mm	2500 units

©2008 Fairchild Semiconductor Corporation

FDS4897AC Rev.C

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Char	acteristics						
BV _{DSS}	Drain to Source Breakdown Voltage	$I_{D} = 250 \ \mu\text{A}, \ V_{GS} = 0 \ V$ $I_{D} = -250 \ \mu\text{A}, \ V_{GS} = 0 \ V$	Q1 Q2	40 -40			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C I_D = -250 μ A, referenced to 25 °C	Q1 Q2		37 -32		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 32 V$, $V_{GS} = 0 V$ $V_{DS} = -32 V$, $V_{GS} = 0 V$	Q1 Q2			1 -1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	Q1 Q2			±100 ±100	nA nA
On Char	acteristics						
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$ $V_{GS} = V_{DS}, I_D = -250 \ \mu A$	Q1 Q2	1.5 -1.5	2.0 -2.0	3.0 -3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C I_D = -250 μ A, referenced to 25 °C	Q1 Q2		-6 6		mV/°C
r	Static Drain to Source On Resistance		Q1		20 24 30	26 31 39	mΩ
r _{DS(on)}			Q2		28 45 41	39 65 57	11152
9 _{FS}	Forward Transconductance	$V_{DD} = 5 V$, $I_D = 6.1 A$ $V_{DD} = -5 V$, $I_D = -5.2 A$	Q1 Q2		24 14		S
Dynamic	Characteristics						
C _{iss}	Input Capacitance	Q1 V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHZ	Q1 Q2		795 765	1055 1015	pF
C _{oss}	Output Capacitance	Q2	Q1 Q2		95 135	130 180	pF
C _{rss}	Reverse Transfer Capacitance	V _{DS} = -20 V, V _{GS} = 0 V, f = 1 MHZ	Q1 Q2		65 80	100 120	pF
R _g	Gate Resistance		Q1 Q2		1.7 3.6		Ω
Switchin	g Characteristics						
t _{d(on)}	Turn-On Delay Time	Q1	Q1 Q2		6 8	12 15	ns
t _r	Rise Time	$V_{DD} = 20 \text{ V}, \text{ I}_{D} = 6.1 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$	Q1 Q2		2 3	10 10	ns
t _{d(off)}	Turn-Off Delay Time	Q2 V _{DD} = -20 V, I _D = -5.2 A,	Q1 Q2		17 17	30 30	ns
t _f	Fall Time	$V_{GS} = -10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$	Q1 Q2		2 3	10 10	ns
Q _{g(TOT)}	Total Gate Charge	Q1 - V _{GS} = 10 V, V _{DD} = 20 V, I _D = 6.1 A	Q1 Q2		15 15	21 20	nC
Q _{gs}	Gate to Source Charge	$V_{GS} = 10$ V, $V_{DD} = 20$ V, $I_D = 6.1$ A	Q1 Q2		2.5 2.6		nC
Q _{gd}	Gate to Drain "Miller" Charge	$V_{GS} = -10 \text{ V}, \text{ V}_{DD} = -20 \text{ V}, \text{ I}_{D} = -5.2 \text{ A}$	Q1 Q2		2.9 3.2		nC

FDS4897AC Dual N & P-Channel PowerTrench[®] MOSFET

©2008 Fairchild Semiconductor Corporation FDS4897AC Rev.C

Symbol	Parameter	Test Conditions		Туре	Min	Тур	Max	Units
Drain-S	ource Diode Characteristics							
V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = 1.3 A$ $V_{GS} = 0 V, I_{S} = -1.3 A$	(Note 2) (Note 2)	Q1 Q2		0.75 -0.76	1.2 -1.2	V
t _{rr}	Reverse Recovery Time	Q1 I _F = 6.1 A, di/dt = 100 A/s		Q1 Q2		17 20	31 36	ns
Q _{rr}	Reverse Recovery Charge	Q2 I _F = -5.2 A, di/dt = 100 A/s		Q1 Q2		7 10	15 20	nC

Notes:
1: R_{θJA} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{θJC} is guaranteed by design while R_{θCA} is determined by the user's board design.



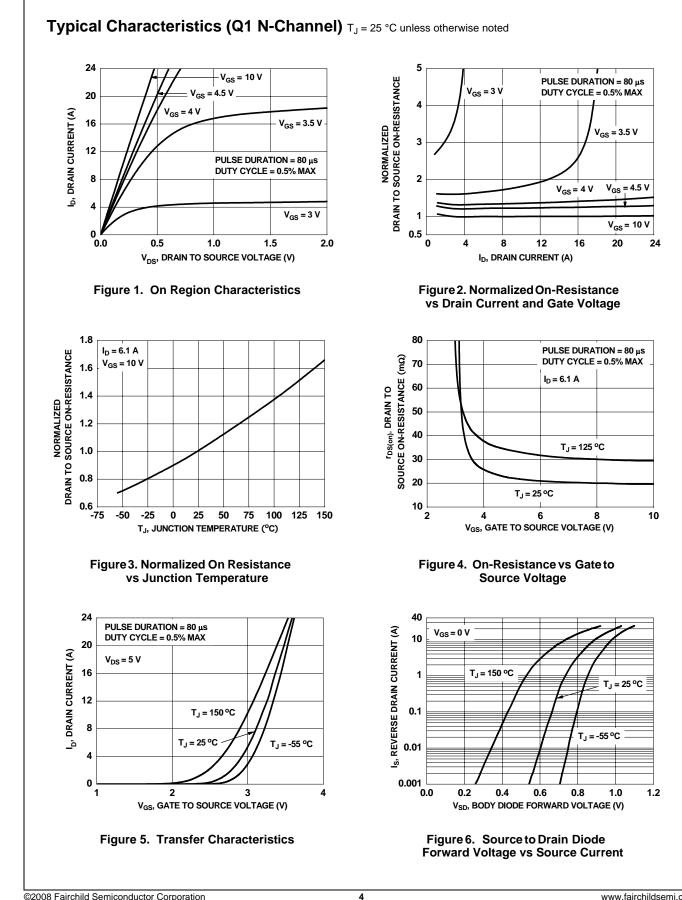
a) 78 °C/W when mounted on a 1 in² pad of 2 oz copper



b) 135 °C/W when mounted on a minimun pad

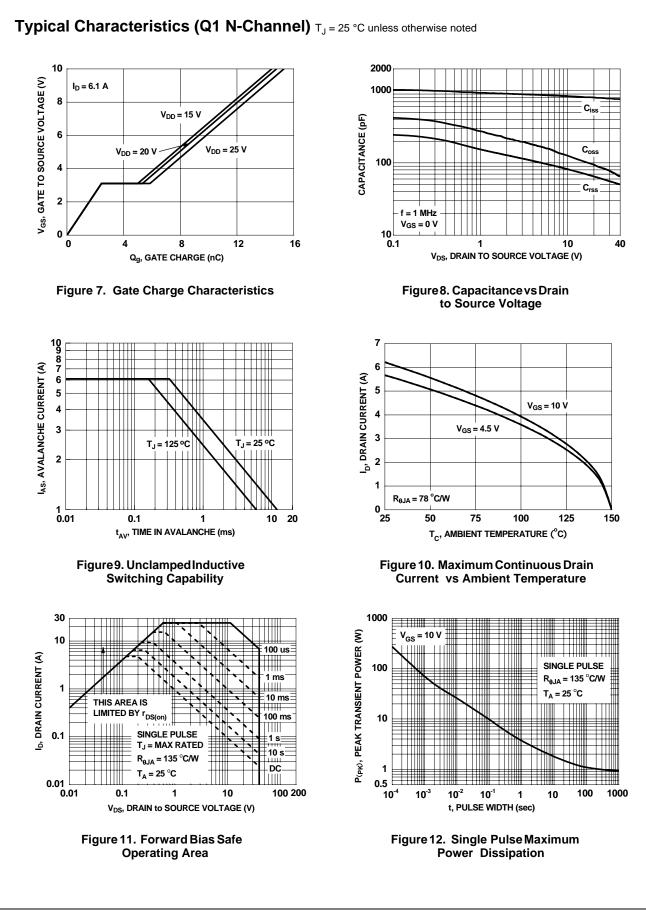
2: Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%. 3: Starting T_J = 25 °C, N-ch: L = 3 mH, I_{AS} = 5 A, V_{DD} = 40 V, V_{GS} = 10 V; P-ch: L = 3 mH, I_{AS} = -7 A, V_{DD} = -40 V, V_{GS} = -10 V.

FDS4897AC Dual N & P-Channel PowerTrench[®] MOSFET

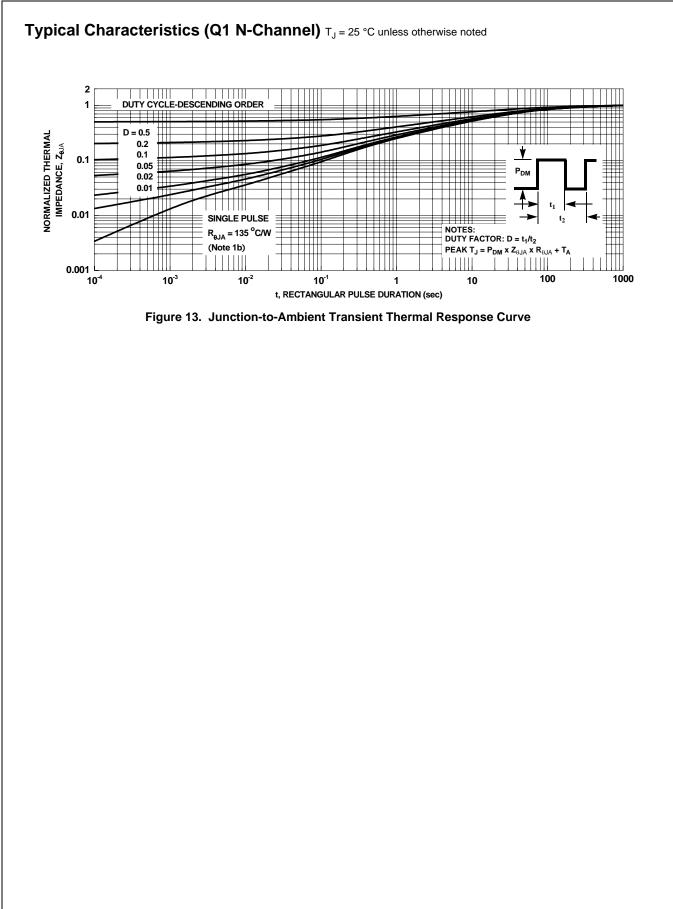


©2008 Fairchild Semiconductor Corporation FDS4897AC Rev.C

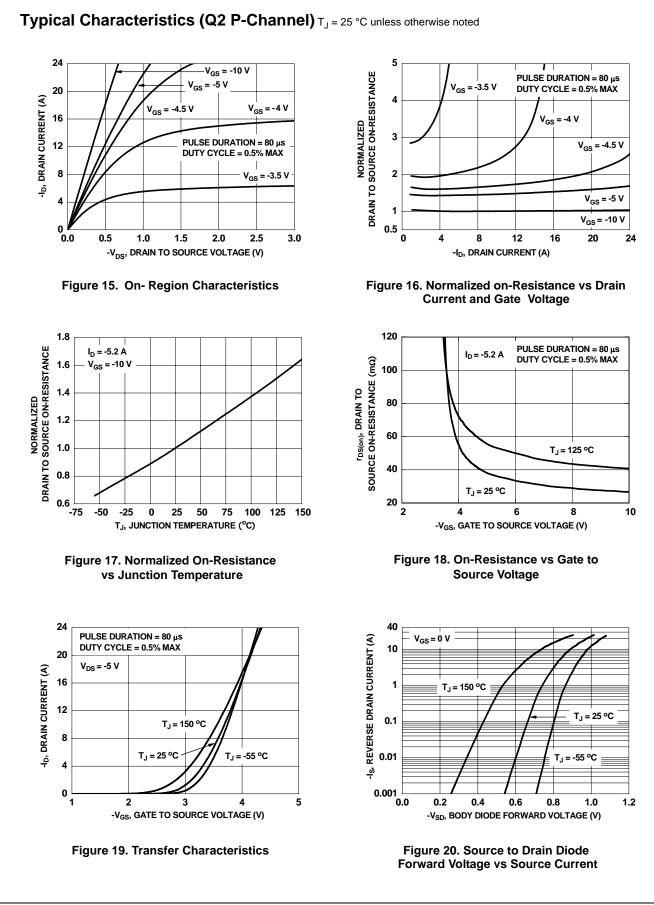




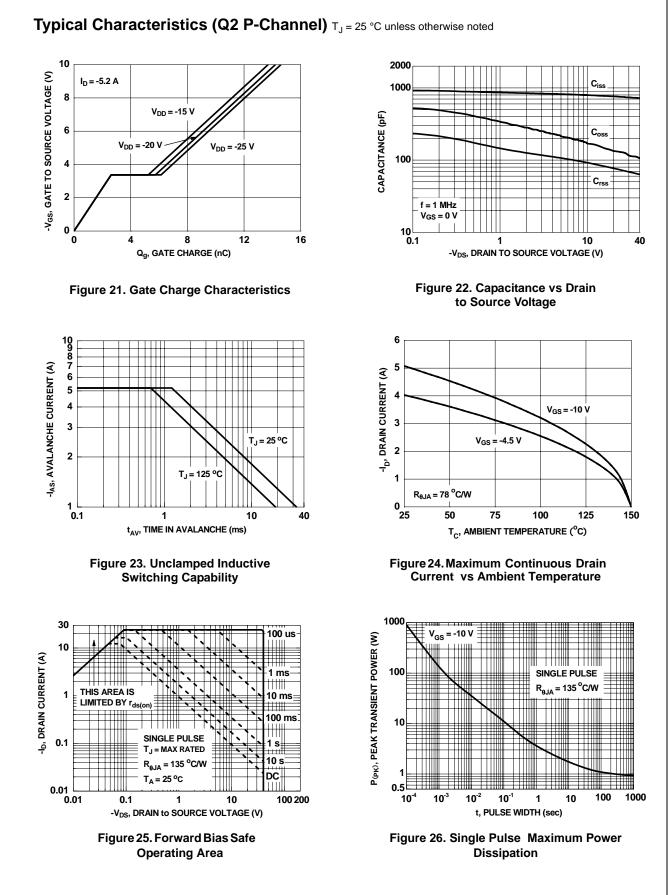
©2008 Fairchild Semiconductor Corporation FDS4897AC Rev.C



FDS4897AC Dual N & P-Channel PowerTrench® MOSFET

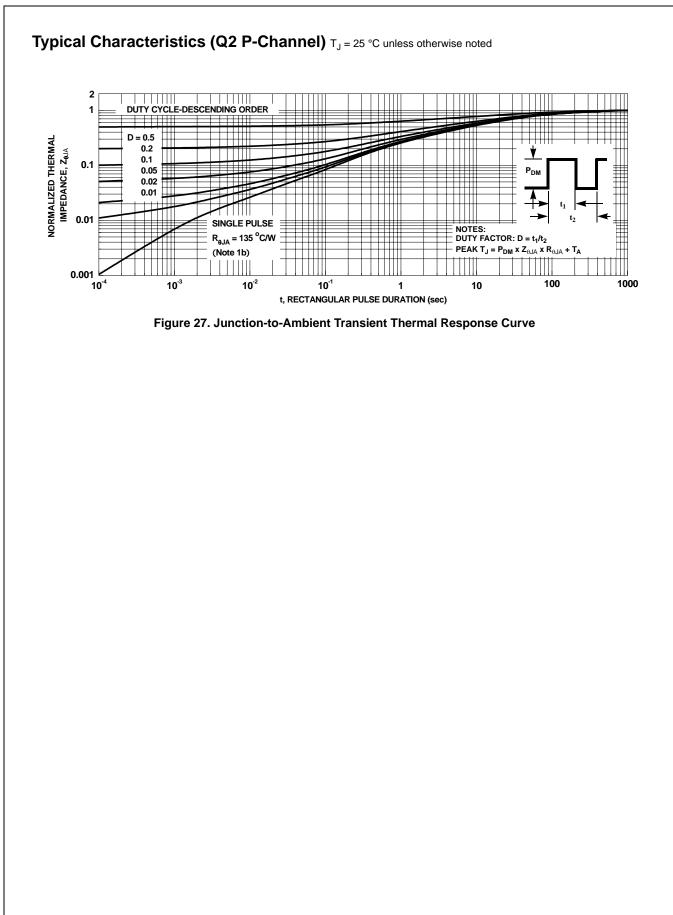


©2008 Fairchild Semiconductor Corporation FDS4897AC Rev.C



©2008 Fairchild Semiconductor Corporation FDS4897AC Rev.C

FDS4897AC Dual N & P-Channel PowerTrench[®] MOSFET



©2008 Fairchild Semiconductor Corporation FDS4897AC Rev.C

FDS4897AC Dual N & P-Channel PowerTrench® MOSFET



SEMICONDUCTOR

TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

FACT® SupreMOS™ VCX™ FAST® Image: SupreMOS™ VCX™ FastvCore™ SyncFET™ VisualMax™ FlashWriter® * PDP SPM™ Esystem ® FPS™ Power-SPM™ The Power Franchise® F-PFS™ PowerXS™ The Power Icense by Fairchild Semiconductor.	FAST [®] FastvCore™ FlashWriter [®] * FPS™ F-PFS™	PDP SPM™ Power-SPM™ PowerTrench [®] PowerXS™	SyncFET™ SYSTEM ® GENERAL The Power Franchise [®]	VisualMax™ XS™
---	---	--	---	-------------------

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Farichild's Anti-Counterfeiting Policy is also stated on our external website, www.fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Farichild strongly encourages customers to purchase Farichild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Farichild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Farichild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

©2008 Fairchild Semiconductor Corporation

FDS4897AC Rev.C